

#### SLOVENSKI STANDARD SIST-TP CLC/TR 62258-8:2008

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Semiconductor die products -- Part 8: EXPRESS model schema for data exchange

Halbleiter-Chip-Erzeugnisse - Teil 8: EXPRESS-Modell-Schema für den Datenaustausch

Produits à puce de semiconducteur - Partie 8. Schéma du modèle EXPRESS pour l'échange de données (standards.iteh.ai)

Ta slovenski standard je istoveten CLC/TR 62258-8:2008

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#### ICS:

31.080.99 Drugi polprevodniški elementi Other semiconductor devices

31.200 Integrirana vezja, Integrated circuits.

mikroelektronika Microelectronics

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SIST-TP CLC/TR 62258-8:2008

**TECHNICAL REPORT** 

**CLC/TR 62258-8** 

RAPPORT TECHNIQUE TECHNISCHER BERICHT

August 2008

ICS 31.080.99

English version

## Semiconductor die products Part 8: EXPRESS model schema for data exchange (IEC/TR 62258-8:2008)

Produits à puce de semiconducteur -Partie 8: Schéma du modèle EXPRESS pour l'échange de données (CEI/TR 62258-8:2008) Halbleiter-Chip-Erzeugnisse -Teil 8: EXPRESS-Modell-Schema für den Datenaustausch (IEC/TR 62258-8:2008)

#### iTeh STANDARD PREVIEW

This Technical Report was approved by CENELEC on 2008-06-01.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Cyprus, the Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovenia, Spain, Sweden, Switzerland and the United Kingdom.

### **CENELEC**

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

#### **Foreword**

The text of document 47/1927/DTR, future edition 1 of IEC/TR 62258-8, prepared by IEC TC 47, Semiconductor devices, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as CLC/TR 62258-8 on 2008-06-01.

Annex ZA has been added by CENELEC.

#### **Endorsement notice**

The text of the Technical Report IEC/TR 62258-8:2008 was approved by CENELEC as a Technical Report without any modification.

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<u>SIST-TP CLC/TR 62258-8:2008</u> https://standards.iteh.ai/catalog/standards/sist/75e93b50-7739-49a1-b0cf-392cca7c52b3/sist-tp-clc-tr-62258-8-2008

### Annex ZA (normative)

### Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60050	Series	International Electrotechnical Vocabulary (IEV)	-	-
IEC 62258-1	_1)	Semiconductor die products - Part 1: Requirements for procurement and use	EN 62258-1	2005 <sup>2)</sup>
IEC 62258-2	_1)	Semiconductor die products - Part 2: Exchange data formats	EN 62258-2	2005 <sup>2)</sup>
IEC/TR 62258-4	_1)	Semiconductor die products - Part 4: Questionnaire for die users and	CLC/TR 62258-4	2007 <sup>2)</sup>
IEC 62258-5	_1) <b>iT</b> (	Semiconductor die products - Part 5: Requirements for information concerning electrical simulation	EN 62258-5	2006 <sup>2)</sup>
IEC 62258-6	_1) https://star	Semiconductor die products - 8.2008 Part 6: Requirements for information -7739-49a concerning thermal simulation 58-8-2008	EN 62258-6 nl-b0cf-	2006 <sup>2)</sup>
ISO 10303-11	2004	Industrial automation systems and integration - Product data representation and exchange - Part 11: Description methods: The EXPRESS language reference manual	-	-
ISO 10303-21	2002	Industrial automation systems and integration - Product data representation and exchange - Part 21: Implementation methods: Clear text encoding of the exchange structure	-	-

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<sup>1)</sup> Undated reference.

<sup>&</sup>lt;sup>2)</sup> Valid edition at date of issue.

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### IEC/TR 62258-8

Edition 1.0 2008-05

# TECHNICAL REPORT

### Semiconductor die products ANDARD PREVIEW Part 8: EXPRESS model schema for data exchange

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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SIST-TP CLC/TR 62258-8:2008

#### INTERNATIONAL ELECTROTECHNICAL COMMISSION

#### SEMICONDUCTOR DIE PRODUCTS -

#### Part 8: EXPRESS model schema for data exchange

#### **FOREWORD**

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The main task of IEC technical committees is to prepare International Standards. However, a technical committee may propose the publication of a technical report when it has collected data of a different kind from that which is normally published as an International Standard, for example "state of the art".

IEC 62258-8, which is a technical report, has been prepared by subcommittee 47: Semiconductor devices.

The text of this technical report is based on the following documents:

Enquiry draft	Report on voting
47/1927/DTR	47/1952/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

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This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62258 series, under the general title *Semiconductor die products*, can be found on the IEC website. Further parts may be added as required.

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The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed.
- withdrawn,
- · replaced by a revised edition, or
- · amended.

A bilingual version of this publication may be issued at a later date.

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#### INTRODUCTION

This technical report is based on the work carried out in the ESPRIT 4<sup>th</sup> Framework project GOODDIE which resulted in the publication of the ES 59008 series of European specifications. Organisations that helped prepare this document included the ESPRIT ENCAST project, the Die Products Consortium, JEITA, JEDEC and ZVEI.

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SIST-TP CLC/TR 62258-8:2008

#### SEMICONDUCTOR DIE PRODUCTS -

#### Part 8: EXPRESS model schema for data exchange

#### 1 Scope

This part of IEC 62258, which is a technical report, has been developed to facilitate the production, supply and use of semiconductor die products, including

- wafers,
- singulated bare die,
- die and wafers with attached connection structures,
- minimally or partially encapsulated die and wafers.

This Technical Report contains an EXPRESS model schema that describes the elements needed for data exchange and that will allow the implementation of the requirements of the IEC 62258-1, IEC 62258-5 and IEC 62258-6 standards, as well as providing an exchange structure that is complementary to those defined in IEC 62258-2. It is also complementary to and compatible with the questionnaire in IEC 62258-4.

#### iTeh STANDARD PREVIEW

#### 2 Normative references (standards.iteh.ai)

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050 (all parts), International Electrotechnical Vocabulary

IEC 62258-1, Semiconductor die products – Part 1: Requirements for procurement and use

IEC 62258-2, Semiconductor die products – Part 2: Exchange data formats

IEC/TR 62258-4, Semiconductor die products – Part 4: Questionnaire for die users and suppliers

IEC 62258-5, Semiconductor die products – Part 5: Requirements for information concerning electrical simulation

IEC 62258-6, Semiconductor die products – Part 6: Requirements for information concerning thermal simulation

ISO 10303-11:2004, Industrial automation systems and integration – Product data representation and exchange – Part 11: Description methods: The EXPRESS language reference manual

ISO 10303-21:2002, Industrial automation systems and integration – Product data representation and exchange – Part 21: Implementation methods: Clear text encoding of the exchange structure